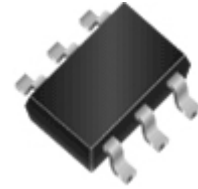
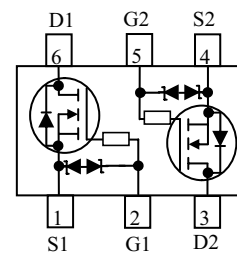


**WNMD2165**
**Dual N-Channel, 60V, 0.32A, Power MOSFET**
[Http://www.sh-willsemi.com](http://www.sh-willsemi.com)

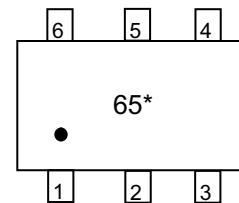
V <sub>DS</sub> (V)	R <sub>ds(on)</sub> (Ω)
60	1.4@ V <sub>GS</sub> =10V
	1.7@ V <sub>GS</sub> =4.5V
ESD Rating:2000V HBM	


**SOT-363**
**Descriptions**

The WNMD2165 is Dual N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent R<sub>DS(ON)</sub> with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WNMD2165 is Pb-free and Halogen-free.


**Pin configuration (Top view)**
**Features**

- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Extremely Low Threshold Voltage
- Small package SOT-363



65 = Device Code  
 \* = Month (A~Z)

**Marking**
**Applications**

- Driver for Relay, Solenoid, Motor, LED etc.
- DC-DC converter circuit
- Power Switch
- Load Switch
- Charging

**Order information**

Device	Package	Shipping
WNMD2165-6/TR	SOT-363	3000/Reel&Tape

**Absolute Maximum ratings**

Parameter		Symbol	10 s	Steady State	Unit
Drain-Source Voltage		$V_{DS}$	60		V
Gate-Source Voltage		$V_{GS}$	$\pm 20$		
Continuous Drain Current <sup>ad</sup>	$T_A=25^\circ\text{C}$	$I_D$	0.32	0.28	A
	$T_A=70^\circ\text{C}$		0.25	0.22	
Maximum Power Dissipation <sup>ad</sup>	$T_A=25^\circ\text{C}$	$P_D$	0.41	0.31	W
	$T_A=70^\circ\text{C}$		0.26	0.20	
Continuous Drain Current <sup>bd</sup>	$T_A=25^\circ\text{C}$	$I_D$	0.26	0.24	A
	$T_A=70^\circ\text{C}$		0.21	0.19	
Maximum Power Dissipation <sup>bd</sup>	$T_A=25^\circ\text{C}$	$P_D$	0.28	0.23	W
	$T_A=70^\circ\text{C}$		0.17	0.15	
Pulsed Drain Current <sup>c</sup>		$I_{DM}$	1.0		A
Operating Junction Temperature		$T_J$	-55 to 150		$^\circ\text{C}$
Lead Temperature		$T_L$	260		$^\circ\text{C}$
Storage Temperature Range		$T_{stg}$	-55 to 150		$^\circ\text{C}$

**Thermal resistance ratings**

Parameter		Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance <sup>a</sup>	$t \leq 10$ s	$R_{\theta JA}$	275	305	$^\circ\text{C/W}$
	Steady State		328	395	
Junction-to-Ambient Thermal Resistance <sup>b</sup>	$t \leq 10$ s	$R_{\theta JA}$	375	445	
	Steady State		446	532	
Junction-to-Case Thermal Resistance		$R_{\theta JC}$	260	300	

a Surface mounted on FR-4 Board using 1 square inch pad size, 1oz copper.

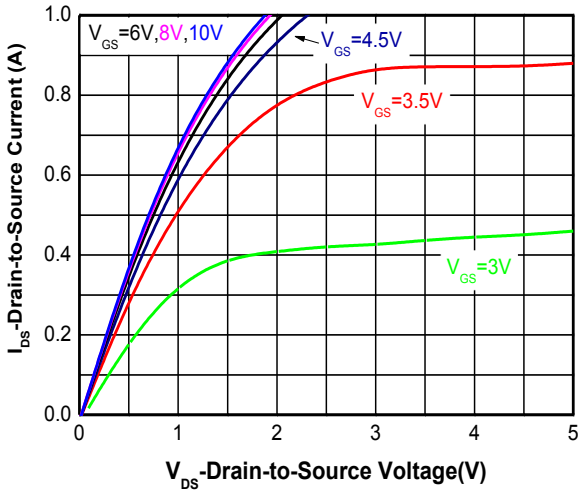
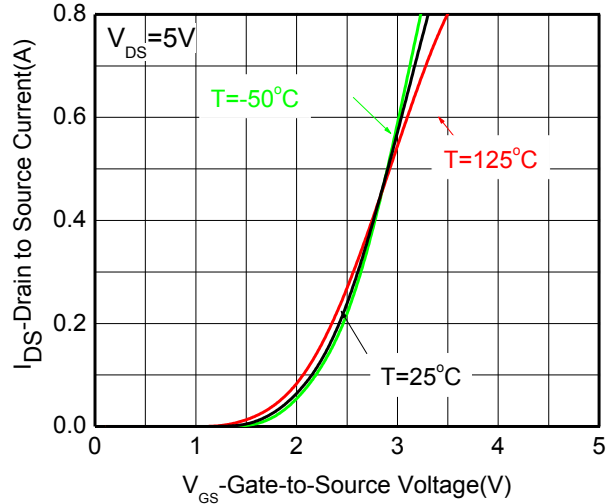
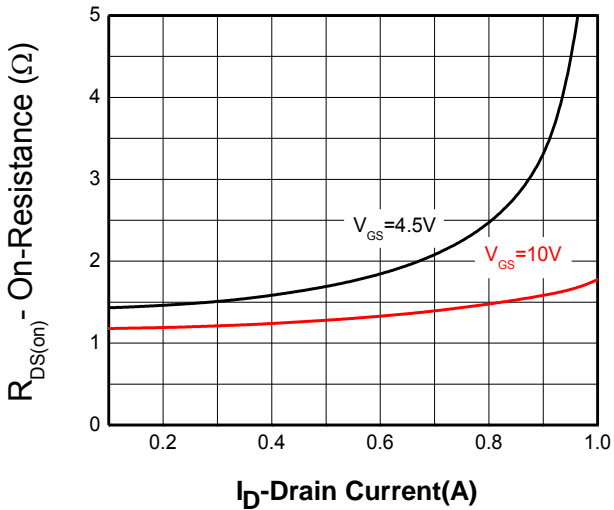
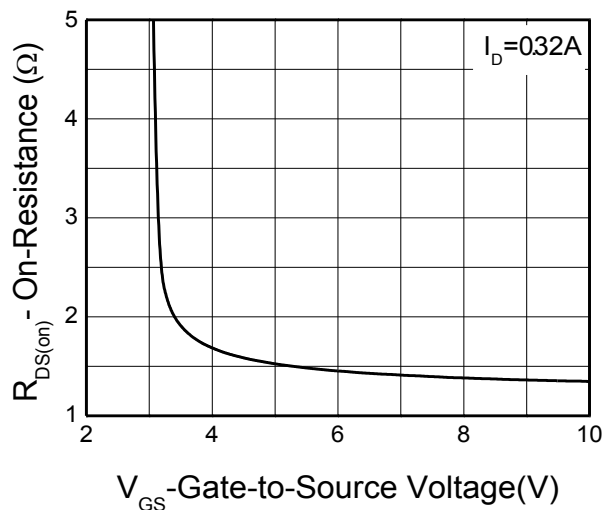
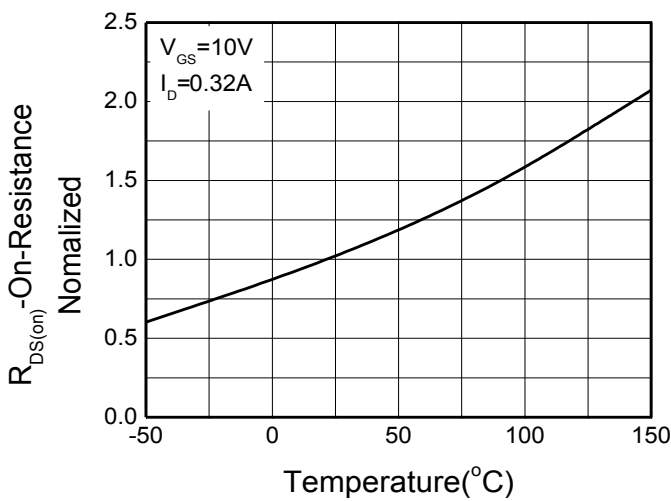
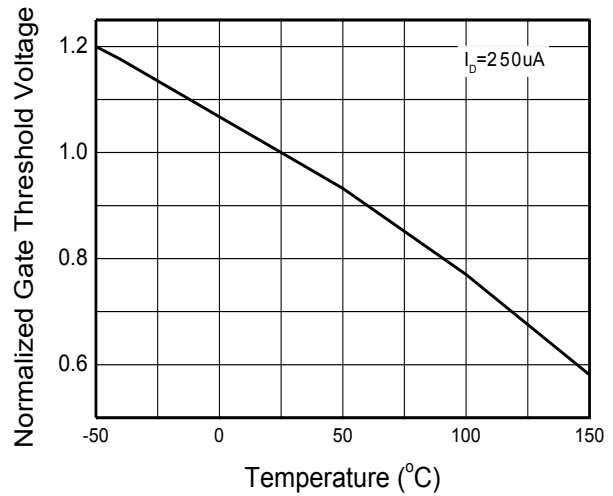
b Surface mounted on FR-4 board using minimum pad size, 1oz copper.

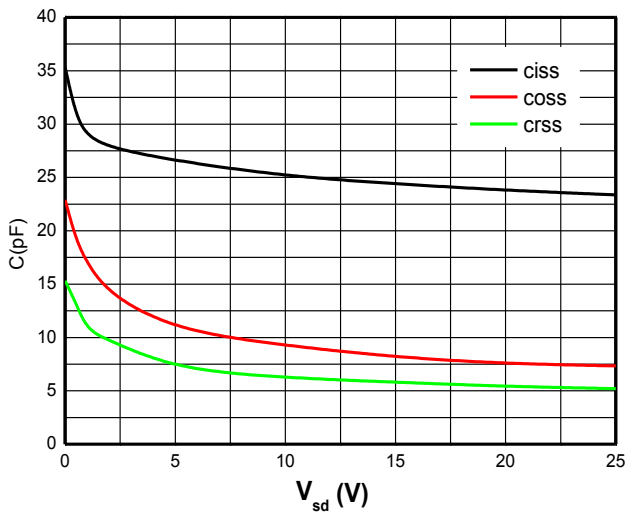
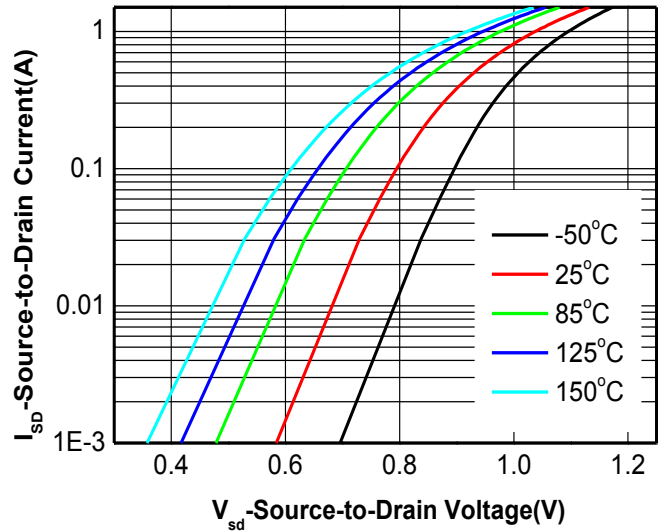
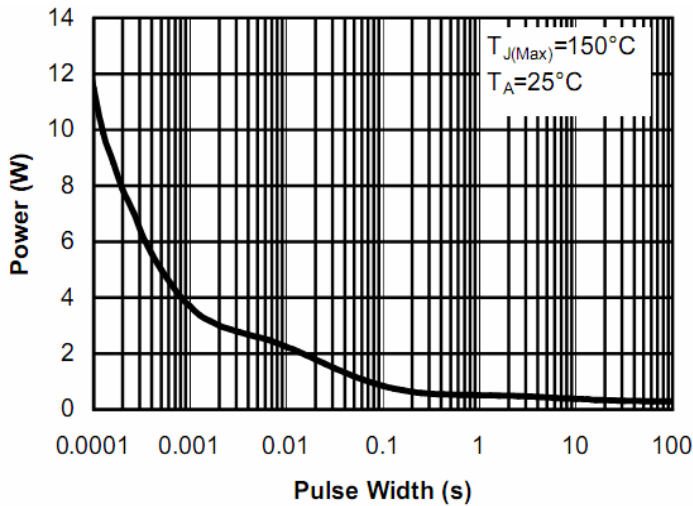
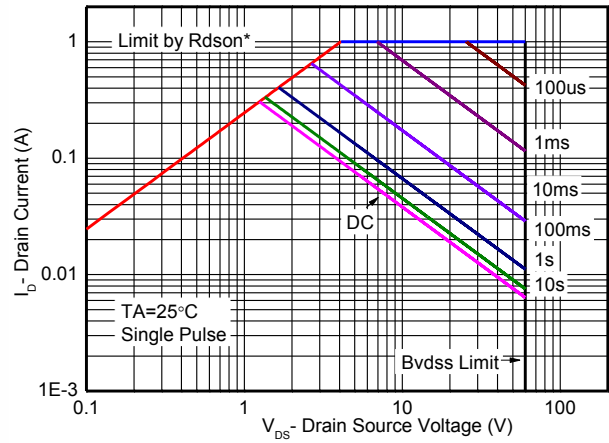
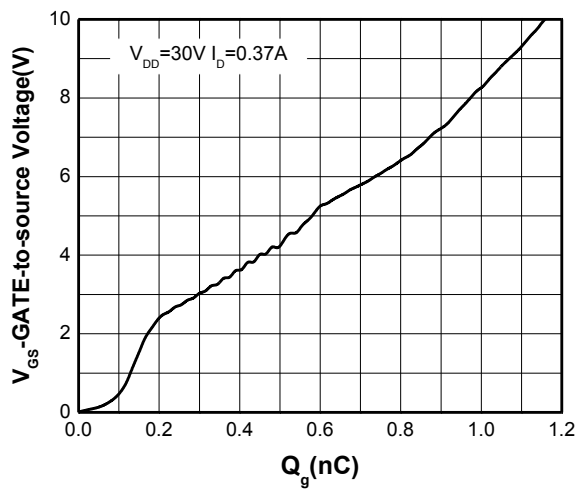
c Pulse width < 380 $\mu\text{s}$ .

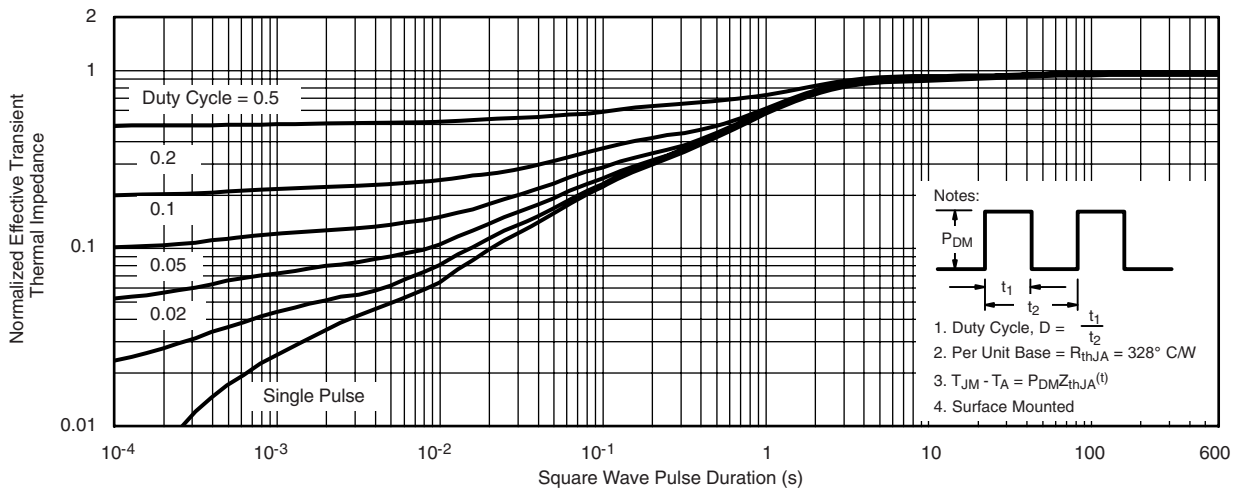
d Maximum junction temperature  $T_J=150^\circ\text{C}$ .

**Electronics Characteristics (Ta=25°C, unless otherwise noted)**

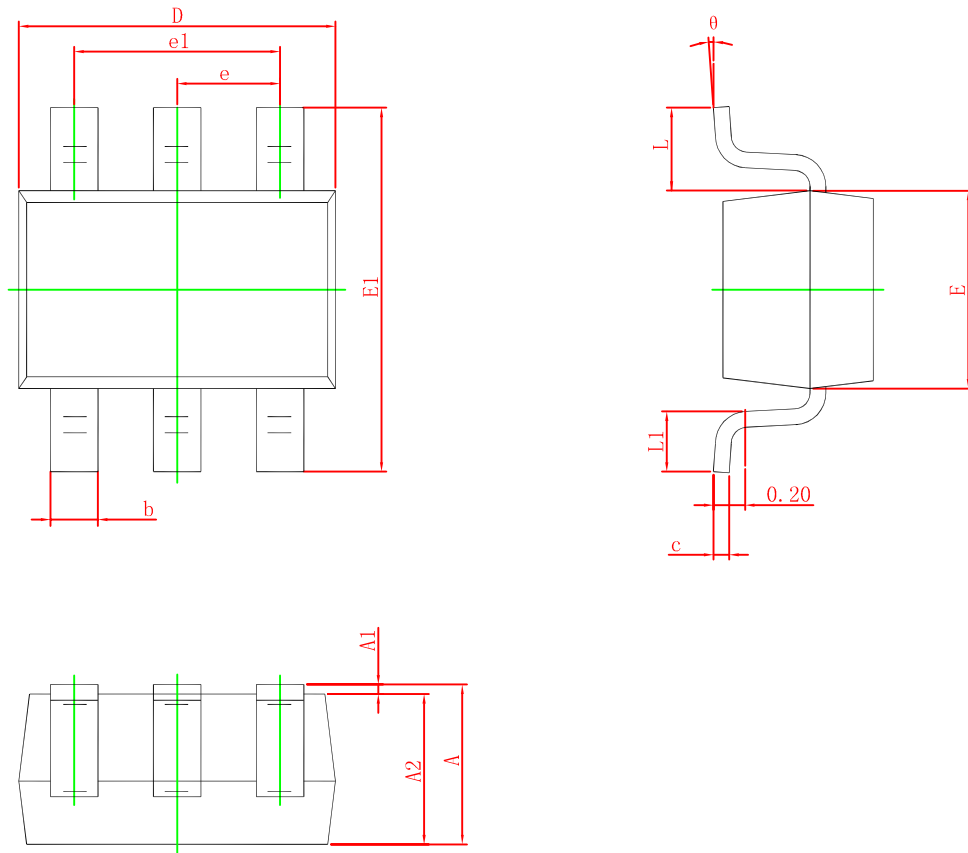
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\mu\text{A}$	60			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 60\text{ V}, V_{GS} = 0\text{ V}$			1	$\mu\text{A}$
Gate-to-source Leakage Current	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$			$\pm 5$	$\mu\text{A}$
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	0.8	1.3	2	V
Drain-to-source On-resistance <sup>b, c</sup>	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 0.32\text{ A}$		1.4	2.0	$\Omega$
		$V_{GS} = 4.5\text{ V}, I_D = 0.2\text{ A}$		1.7	2.6	
Forward Transconductance	$g_{FS}$	$V_{DS} = 15\text{ V}, I_D = 0.25\text{ A}$		0.42		S
<b>CAPACITANCES, CHARGES</b>						
Input Capacitance	$C_{ISS}$	$V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz},$ $V_{DS} = 25\text{ V}$		23.37		pF
Output Capacitance	$C_{OSS}$			7.33		
Reverse Transfer Capacitance	$C_{RSS}$			5.2		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 10\text{ V},$ $V_{DD} = 30\text{ V},$ $I_D = 0.37\text{ A}$		1.2		nC
Threshold Gate Charge	$Q_{G(TH)}$			0.15		
Gate-to-Source Charge	$Q_{GS}$			0.21		
Gate-to-Drain Charge	$Q_{GD}$			0.12		
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	$t_d(ON)$	$V_{DD} = 30\text{ V}, R_L = 150\Omega$ $I_D = 0.2\text{ A}, V_{GEN} = 10\text{ V},$ $R_G = 10\Omega$		7.6		ns
Rise Time	$t_r$			5.1		
Turn-Off Delay Time	$t_d(OFF)$			24.6		
Fall Time	$t_f$			10		
<b>BODY DIODE CHARACTERISTICS</b>						
Forward Voltage	$V_{SD}$	$V_{GS} = 0\text{ V}, I_S = 0.3\text{ A}$		0.9	1.5	V

**Typical Characteristics (Ta=25°C, unless otherwise noted)**

**Output characteristics**

**Transfer characteristics**

**On-Resistance vs. Drain current**

**On-Resistance vs. Gate-to-Source voltage**

**On-Resistance vs. Junction temperature**

**Threshold voltage vs. Temperature**


**Capacitance**

**Body diode forward voltage**

**Single pulse power**

**Safe operating power**

**Gate Charge Characteristics**



**Transient thermal response (Junction-to-Ambient)**

**Package outline dimensions**
**SOT-363**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.100	0.035	0.043
A1	0.000	0.100	0.000	0.004
A2	0.900	1.000	0.035	0.039
b	0.150	0.350	0.006	0.014
c	0.080	0.150	0.003	0.006
D	2.000	2.200	0.079	0.087
E	1.150	1.350	0.045	0.053
E1	2.150	2.450	0.085	0.096
e	0.650 TYP.		0.026 TYP.	
e1	1.200	1.400	0.047	0.055
L	0.525 REF.		0.021 REF.	
L1	0.260	0.460	0.010	0.018
$\theta$	0°	8°	0°	8°